

## September 2008

# FDMS9600S Dual N-Channel PowerTrench<sup>®</sup> MOSFET

Q1: 30V, 32A, 8.5m $\Omega$  Q2: 30V, 30A, 5.5m $\Omega$ 

## Features

#### Q1: N-Channel

- Max  $r_{DS(on)}$  = 8.5m $\Omega$  at V<sub>GS</sub> = 10V, I<sub>D</sub> = 12A
- Max  $r_{DS(on)}$  = 12.4m $\Omega$  at V<sub>GS</sub> = 4.5V, I<sub>D</sub> = 10A

#### Q2: N-Channel

- Max  $r_{DS(on)}$  = 5.5m $\Omega$  at V<sub>GS</sub> = 10V, I<sub>D</sub> = 16A
- Max  $r_{DS(on)}$  = 7.0m $\Omega$  at  $V_{GS}$  = 4.5V,  $I_D$  = 14A
- Low Qg high side MOSFET
- Low r<sub>DS(on)</sub> low side MOSFET
- Thermally efficient dual Power 56 package
- Pinout optimized for simple PCB design
- RoHS Compliant

# General Description

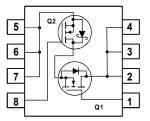
This device includes two specialized MOSFETs in a unique dual Power 56 package. It is designed to provide an optimal Synchronous Buck power stage in terms of efficiency and PCB utilization. The low switching loss "High Side" MOSFET is complemented by a Low Conduction Loss "Low Side" SyncFET.

## Applications

Synchronous Buck Converter for:

- Notebook System Power
- General Purpose Point of Load





## MOSFET Maximum Ratings T<sub>A</sub> = 25°C unless otherwise noted

| Symbol                            | Parameter   |           | Q1     | Q2   | Units |
|-----------------------------------|---|-----------|--------|------|-------|
| V <sub>DS</sub>                   | Drain to Source Voltage   |           | 30     | 30   | V     |
| V <sub>GS</sub>                   | Gate to Source Voltage  |           | ±20    | ±20  | V     |
|                                   | Drain Current -Continuous (Package limited) T <sub>C</sub> = 25°C |           | 32     | 30   |       |
| 1                                 | -Continuous (Silicon limited) T <sub>C</sub> = 25°C               |           | 55     | 108  | ^     |
| Ъ                                 | -Continuous T <sub>A</sub> = 25°C                                 | (Note 1a) | 12     | 16   | A     |
|                                   | -Pulsed   |           | 60     | 60   | _     |
| D                                 | Power Dissipation for Single Operation                            | (Note 1a) | 2.     | 5    | w     |
| P <sub>D</sub>                    |   | (Note 1b) | 1.     | .0   | vv    |
| T <sub>J</sub> , T <sub>STG</sub> | Operating and Storage Junction Temperature Range                  |           | -55 to | +150 | °C    |

### **Thermal Characteristics**

| $R_{	ext{	heta}JA}$ | Thermal Resistance, Junction to Ambient (Note 1a) | la) 50    |  |      |
|---------------------|---|-----------|--|------|
| $R_{\thetaJA}$      | Thermal Resistance, Junction to Ambient (Note 1b) | b) 120 °( |  | °C/W |
| $R_{	ext{	heta}JC}$ | Thermal Resistance, Junction to Case              | 3 1.2     |  |      |

## Package Marking and Ordering Information

| Γ | Device Marking | Device    | Package  | Reel Size | Tape Width | Quantity   |
|---|----------------|-----------|----------|-----------|------------|------------|
|   | FDMS9600S      | FDMS9600S | Power 56 | 13"       | 12mm       | 3000 units |

| Symbol  | Parameter  | Test Conditions  | Туре     | Min               | Тур               | Мах                 | Units    |
|---|--|--|----------|-------------------|-------------------|---------------------|----------|
| Off Chara   | acteristics  |  |          |                   |                   |                     |          |
| BV <sub>DSS</sub>                                 | Drain to Source Breakdown Voltage  | $I_D = 250 \mu A, V_{GS} = 0V$<br>$I_D = 1mA, V_{GS} = 0V$   | Q1<br>Q2 | 30<br>30          |                   |                     | V        |
| $\frac{\Delta BV_{DSS}}{\Delta T_J}$              | Breakdown Voltage Temperature<br>Coefficient   | $I_D = 250\mu$ A, referenced to 25°C<br>$I_D = 1$ mA, referenced to 25°C                                 | Q1<br>Q2 |                   | 35<br>29          |                     | mV/°C    |
| I <sub>DSS</sub>                                  | Zero Gate Voltage Drain Current  | V <sub>DS</sub> = 24V, V <sub>GS</sub> = 0V  | Q1<br>Q2 |                   |                   | 1<br>500            | μA       |
| I <sub>GSS</sub>                                  | Gate to Source Leakage Current   | V <sub>GS</sub> = ±20V, V <sub>DS</sub> = 0V   | Q1<br>Q2 |                   |                   | ±100<br>±100        | nA<br>nA |
| On Chara  | cteristics   |  |          |                   |                   |                     |          |
| V <sub>GS(th)</sub>                               | Gate to Source Threshold Voltage   | $V_{GS} = V_{DS}$ , $I_D = 250\mu A$<br>$V_{GS} = V_{DS}$ , $I_D = 1mA$                                  | Q1<br>Q2 | 1<br>1            | 1.5<br>1.8        | 3<br>3              | V        |
| $rac{\Delta V_{GS(th)}}{\Delta T_J}$             | Gate to Source Threshold Voltage<br>Temperature Coefficient  | $I_D = 250\mu$ A, referenced to 25°C<br>$I_D = 1$ mA, referenced to 25°C                                 | Q1<br>Q2 |                   | -4.5<br>-6.0      |                     | mV/°C    |
|   | Durin to Course On Desistance  | $V_{GS} = 10V, I_D = 12A$<br>$V_{GS} = 4.5V, I_D = 10A$<br>$V_{GS} = 10V, I_D = 12A, T_J = 125^{\circ}C$ | Q1       |                   | 7.0<br>9.2<br>8.6 | 8.5<br>12.4<br>13.0 |          |
| r <sub>DS(on)</sub> Drain to Source On Resistance | $V_{GS} = 10V, I_D = 16A$<br>$V_{GS} = 4.5V, I_D = 14A$<br>$V_{GS} = 10V, I_D = 16A, T_J = 125^{\circ}C$ | Q2   |          | 4.5<br>5.3<br>5.4 | 5.5<br>7.0<br>8.3 | - mΩ                |          |
| 9 <sub>FS</sub>                                   | Forward Transconductance   | $V_{DD} = 10V, I_D = 12A$<br>$V_{DD} = 10V, I_D = 16A$   | Q1<br>Q2 |                   | 54<br>68          |                     | S        |

# **Dynamic Characteristics**

| C <sub>iss</sub> | Input Capacitance            |  | Q1<br>Q2 | 1280<br>2300 | 1705<br>3060 | pF |
|------------------|------------------------------|--|----------|--------------|--------------|----|
| C <sub>oss</sub> | Output Capacitance           | V <sub>DS</sub> = 15V, V <sub>GS</sub> = 0V, f= 1MHz | Q1<br>Q2 | 525<br>1545  | 700<br>2055  | pF |
| C <sub>rss</sub> | Reverse Transfer Capacitance |  | Q1<br>Q2 | 80<br>250    | 120<br>375   | pF |
| R <sub>g</sub>   | Gate Resistance              | f = 1MHz   | Q1<br>Q2 | 1.0<br>1.7   |              | Ω  |

## **Switching Characteristics**

| t <sub>d(on)</sub>  | Turn-On Delay Time            |   | Q1<br>Q2 | 13<br>17   | 23<br>31 | ns |
|---------------------|-------------------------------|---|----------|------------|----------|----|
| t <sub>r</sub>      | Rise Time                     | V <sub>DD</sub> = 10V, I <sub>D</sub> = 1A,                               | Q1<br>Q2 | 6<br>11    | 12<br>20 | ns |
| t <sub>d(off)</sub> | Turn-Off Delay Time           | $V_{GS} = 10V, R_{GEN} = 6\Omega$   | Q1<br>Q2 | 42<br>54   | 67<br>86 | ns |
| t <sub>f</sub>      | Fall Time                     |   | Q1<br>Q2 | 12<br>32   | 22<br>51 | ns |
| Q <sub>g(TOT)</sub> | Total Gate Charge             | Q1<br>V <sub>DD</sub> = 15V, V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 12A | Q1<br>Q2 | 9<br>21    | 13<br>29 | nC |
| Q <sub>gs</sub>     | Gate to Source Gate Charge    | Q2  | Q1<br>Q2 | 3<br>8     |          | nC |
| Q <sub>gd</sub>     | Gate to Drain "Miller" Charge | V <sub>DD</sub> = 15V, V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 16A       | Q1<br>Q2 | 2.7<br>6.5 |          | nC |

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| Symbol          | Parameter                             | Test Conditions  |                               | Туре           | Min | Тур               | Мах               | Units |
|-----------------|---------------------------------------|--|-------------------------------|----------------|-----|-------------------|-------------------|-------|
| Drain-Sou       | urce Diode Characteristics            |  |                               |                |     |                   |                   |       |
| I <sub>S</sub>  | Maximum Continuous Drain-Source Dio   | de Forward Current   |                               | Q1<br>Q2       |     |                   | 2.1<br>3.5        | А     |
| V <sub>SD</sub> | Source to Drain Diode Forward Voltage | $\label{eq:VGS} \begin{array}{ll} V_{GS} = 0V, \ I_S = 2.1A & (N \\ V_{GS} = 0V, \ I_S = 3.5A & (N \\ V_{GS} = 0V, \ I_S = 8.2A & (N \\ \end{array}$ | Note 2)<br>Note 2)<br>Note 2) | Q1<br>Q2<br>Q2 |     | 0.7<br>0.4<br>0.5 | 1.2<br>1.0<br>1.0 | v     |
| t <sub>rr</sub> | Reverse Recovery Time                 | Q1<br>I <sub>F</sub> = 12A, di/dt = 100A/μs  |                               | Q1<br>Q2       |     | 33<br>27          |                   | ns    |
| Q <sub>rr</sub> | Reverse Recovery Charge               | Q2<br>I <sub>F</sub> = 16A, di/dt = 300A/μs  |                               | Q1<br>Q2       |     | 20<br>33          |                   | nC    |

Notes:
R<sub>0JA</sub> is determined with the device mounted on a 1in<sup>2</sup> pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R<sub>0JC</sub> is guaranteed by design while R<sub>0CA</sub> is determined by the user's board design.



2: Pulse Test: Pulse Width < 300µs, Duty cycle < 2.0%.

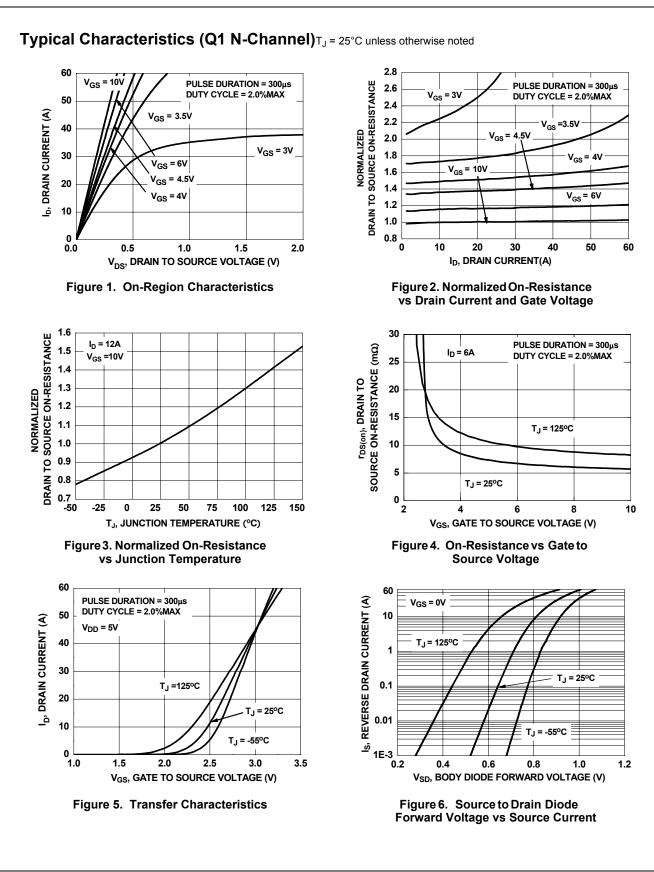
a.50°C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper



b. 120°C/W when mounted on a minimum pad of 2 oz copper

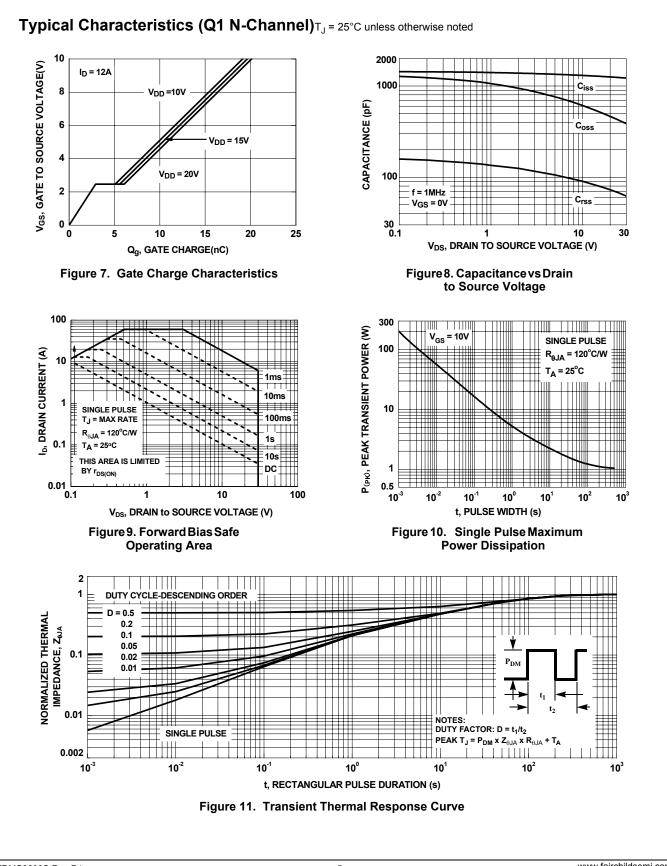
FDMS9600S Dual N-Channel PowerTrench<sup>®</sup> MOSFET



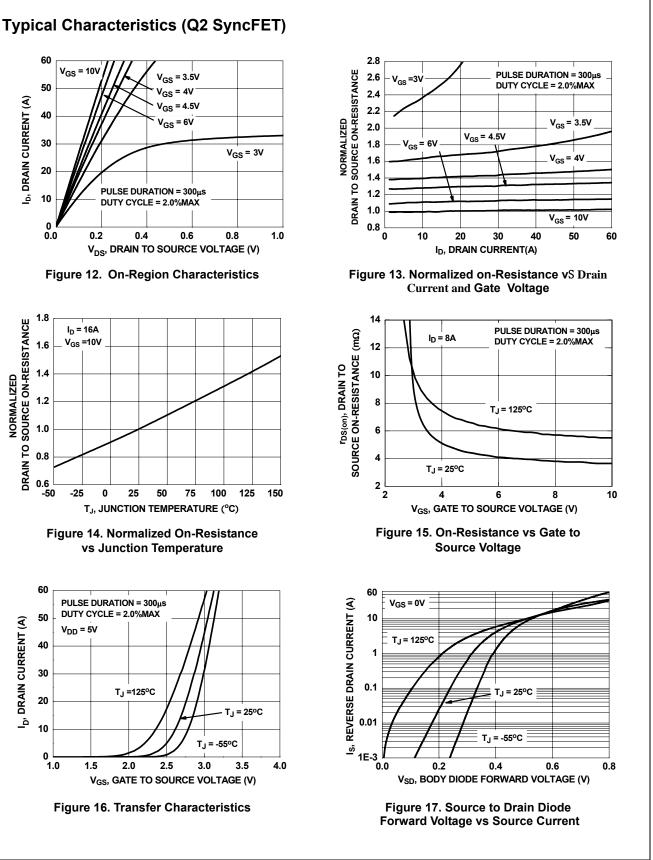


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60

50

40

30

20

10

Λ

0.0

1.8

1.6

1.4

1.2

1.0

0.8

0.6 -50

60

50

40

30

20

10

0 1.0

I<sub>D</sub>, DRAIN CURRENT (A)

-25

V<sub>DD</sub> = 5V

1.5

DRAIN TO SOURCE ON-RESISTANCE

NORMALIZED

ID, DRAIN CURRENT (A)

V<sub>GS</sub> = 10V

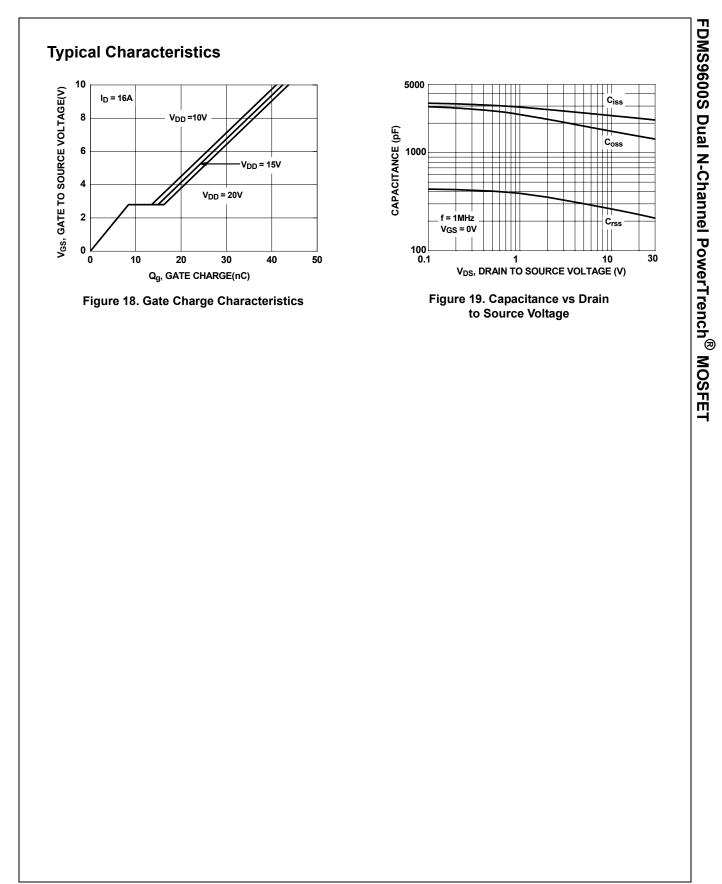
0.2

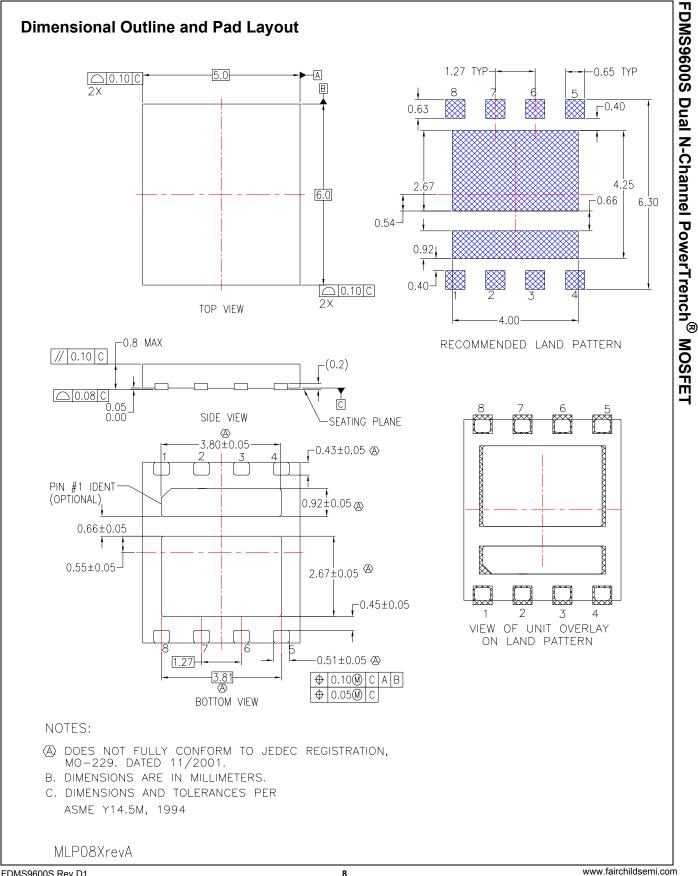
I<sub>D</sub> = 16A

V<sub>GS</sub> =10V

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|---|---|--|---|

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